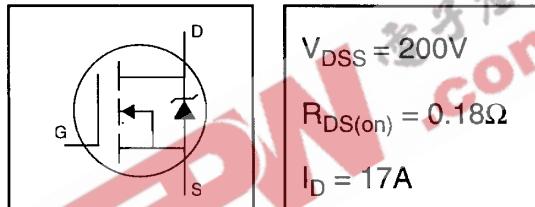


IRL640S

HEXFET® Power MOSFET

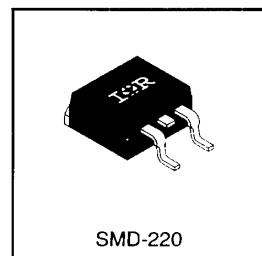
- Surface Mount
- Available in Tape & Reel
- Dynamic dv/dt Rating
- Repetitive Avalanche Rated
- Logic-Level Gate Drive
- $R_{DS(on)}$ Specified at $V_{GS}=4V$ & $5V$
- Fast Switching



Description

Third Generation HEXFETs from International Rectifier provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The SMD-220 is a surface mount power package capable of accommodating die sizes up to HEX-4. It provides the highest power capability and the lowest possible on-resistance in any existing surface mount package. The SMD-220 is suitable for high current applications because of its low internal connection resistance and can dissipate up to 2.0W in a typical surface mount application.



SMD-220

Absolute Maximum Ratings

	Parameter	Max.	Units
$I_D @ T_C = 25^\circ C$	Continuous Drain Current, $V_{GS} @ 5.0 V$	17	
$I_D @ T_C = 100^\circ C$	Continuous Drain Current, $V_{GS} @ 5.0 V$	11	A
I_{DM}	Pulsed Drain Current ①	68	
$P_D @ T_C = 25^\circ C$	Power Dissipation	125	
$P_D @ T_A = 25^\circ C$	Power Dissipation (PCB Mount)**	3.1	W
	Linear Derating Factor	1.0	
	Linear Derating Factor (PCB Mount)**	0.025	W/°C
V_{GS}	Gate-to-Source Voltage	±10	V
E_{AS}	Single Pulse Avalanche Energy ②	580	mJ
I_{AR}	Avalanche Current ①	10	A
E_{AR}	Repetitive Avalanche Energy ①	13	mJ
dv/dt	Peak Diode Recovery dv/dt ③	5.0	V/ns
T_J, T_{STG}	Junction and Storage Temperature Range	-55 to +150	°C
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	

Thermal Resistance

	Parameter	Min.	Typ.	Max.	Units
R_{JC}	Junction-to-Case	—	—	1.0	
R_{JA}	Junction-to-Ambient (PCB mount)**	—	—	40	°C/W
R_{RA}	Junction-to-Ambient	—	—	62	

** When mounted on 1" square PCB (FR-4 or G-10 Material).

For recommended footprint and soldering techniques refer to application note #AN-994.

IRL640S



Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Test Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	200	—	—	V	$V_{GS}=0\text{V}, I_D=250\mu\text{A}$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	—	0.27	—	V/ $^\circ\text{C}$	Reference to $25^\circ\text{C}, I_D=1\text{mA}$
$R_{DS(on)}$	Static Drain-to-Source On-Resistance	—	—	0.18	Ω	$V_{GS}=5.0\text{V}, I_D=10\text{A}$ ④
		—	—	0.27	Ω	$V_{GS}=4.0\text{V}, I_D=8.5\text{A}$ ④
$V_{GS(th)}$	Gate Threshold Voltage	1.0	—	2.0	V	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$
g_f	Forward Transconductance	16	—	—	S	$V_{DS}=50\text{V}, I_D=10\text{A}$ ④
I_{DSS}	Drain-to-Source Leakage Current	—	—	25	μA	$V_{DS}=200\text{V}, V_{GS}=0\text{V}$
		—	—	250	μA	$V_{DS}=160\text{V}, V_{GS}=0\text{V}, T_J=125^\circ\text{C}$
I_{GSS}	Gate-to-Source Forward Leakage	—	—	100	nA	$V_{GS}=10\text{V}$
	Gate-to-Source Reverse Leakage	—	—	-100	nA	$V_{GS}=-10\text{V}$
Q_g	Total Gate Charge	—	—	66	nC	$I_D=17\text{A}$
Q_{gs}	Gate-to-Source Charge	—	—	9.0	nC	$V_{DS}=160\text{V}$
Q_{gd}	Gate-to-Drain ("Miller") Charge	—	—	38	nC	$V_{GS}=5.0\text{V}$ See Fig. 6 and 13 ④
$t_{d(on)}$	Turn-On Delay Time	—	8.0	—	ns	$V_{DD}=100\text{V}$
t_r	Rise Time	—	83	—	ns	$I_D=17\text{A}$
$t_{d(off)}$	Turn-Off Delay Time	—	44	—	ns	$R_G=4.6\Omega$
t_f	Fall Time	—	52	—	ns	$R_D=5.7\Omega$ See Figure 10 ④
L_D	Internal Drain Inductance	—	4.5	—	nH	Between lead, 6 mm (0.25in.) from package and center of die contact
L_S	Internal Source Inductance	—	7.5	—	nH	
C_{iss}	Input Capacitance	—	1800	—	pF	$V_{GS}=0\text{V}$
C_{oss}	Output Capacitance	—	400	—	pF	$V_{DS}=25\text{V}$
C_{rss}	Reverse Transfer Capacitance	—	120	—	pF	$f=1.0\text{MHz}$ See Figure 5

Source-Drain Ratings and Characteristics

	Parameter	Min.	Typ.	Max.	Units	Test Conditions
I_S	Continuous Source Current (Body Diode)	—	—	17	A	MOSFET symbol showing the integral reverse p-n junction diode.
I_{SM}	Pulsed Source Current (Body Diode) ①	—	—	68	A	
V_{SD}	Diode Forward Voltage	—	—	2.0	V	$T_J=25^\circ\text{C}, I_S=17\text{A}, V_{GS}=0\text{V}$ ④
t_{rr}	Reverse Recovery Time	—	310	470	ns	$T_J=25^\circ\text{C}, I_F=17\text{A}$
Q_{rr}	Reverse Recovery Charge	—	3.2	4.8	μC	$dI/dt=100\text{A}/\mu\text{s}$ ④
t_{ton}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by L_S+L_D)				

Notes:

① Repetitive rating; pulse width limited by max. junction temperature (See Figure 11)

② $I_{SD}\leq 17\text{A}$, $dI/dt\leq 150\text{A}/\mu\text{s}$, $V_{DD}\leq V_{(BR)DSS}$, $T_J\leq 150^\circ\text{C}$

③ $V_{DD}=50\text{V}$, starting $T_J=25^\circ\text{C}$, $L=3.0\text{mH}$
 $R_G=25\Omega$, $I_{AS}=17\text{A}$ (See Figure 12)

④ Pulse width $\leq 300\ \mu\text{s}$; duty cycle $\leq 2\%$.

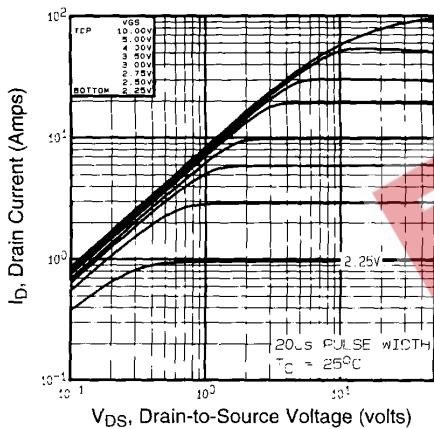
IC2R**IRL640S**

Fig 1. Typical Output Characteristics,
 $T_c = 25^\circ\text{C}$

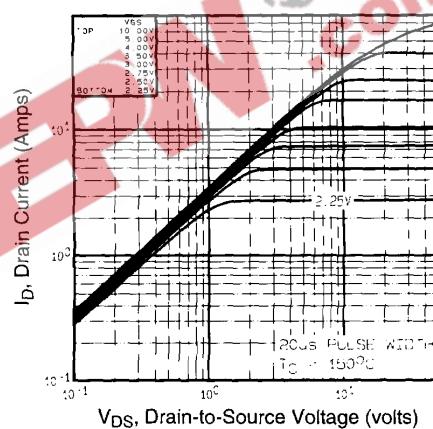


Fig 2. Typical Output Characteristics,
 $T_c = 150^\circ\text{C}$

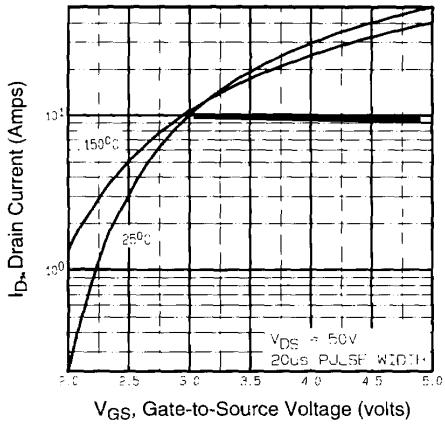


Fig 3. Typical Transfer Characteristics

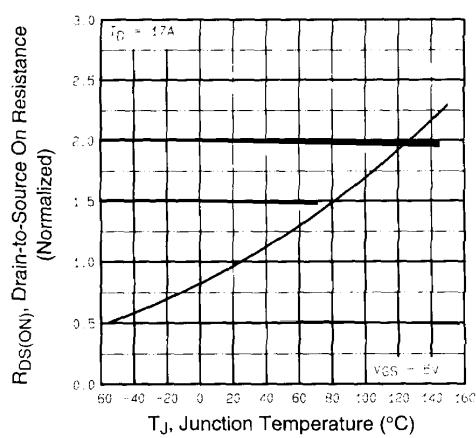


Fig 4. Normalized On-Resistance
Vs. Temperature

IRL640S

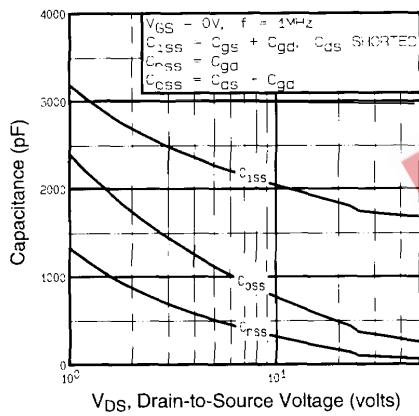


Fig 5. Typical Capacitance Vs.
Drain-to-Source Voltage

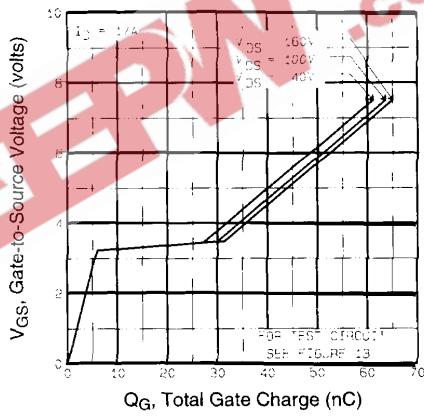


Fig 6. Typical Gate Charge Vs.
Gate-to-Source Voltage

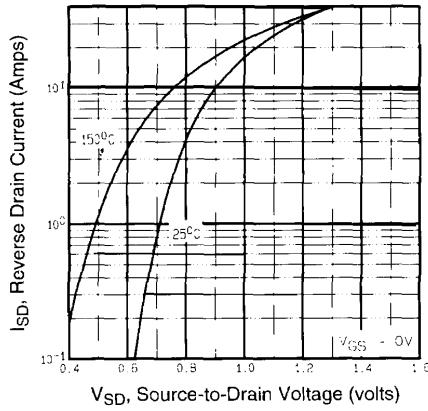


Fig 7. Typical Source-Drain Diode
Forward Voltage

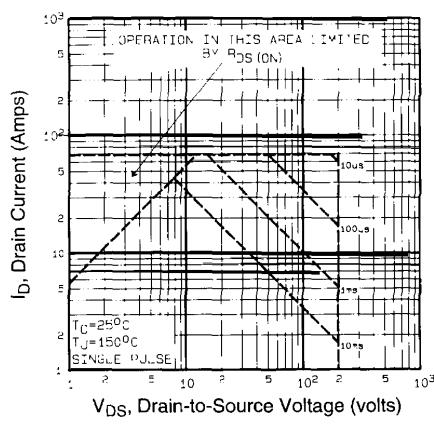


Fig 8. Maximum Safe Operating Area

ICR

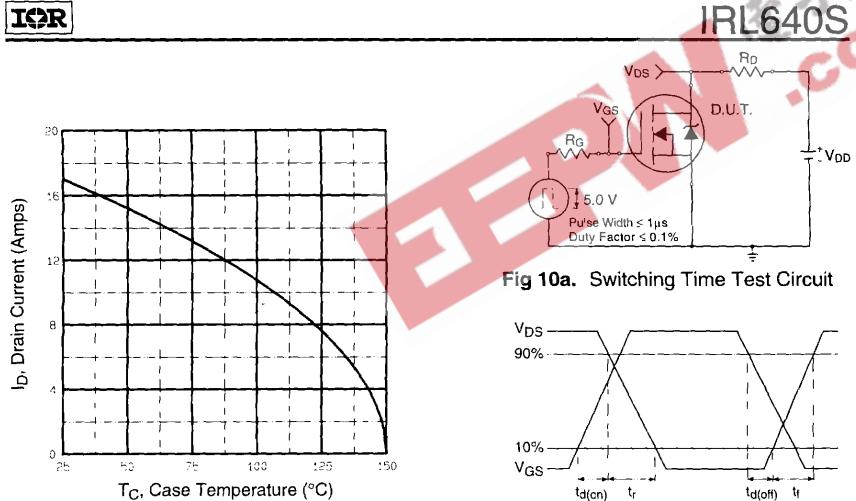


Fig 10b. Switching Time Waveforms

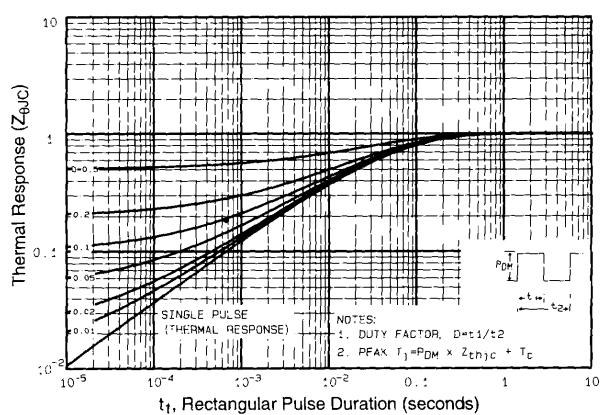
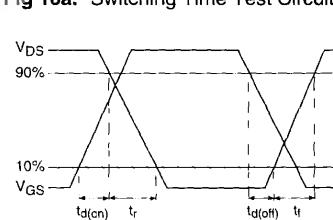


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

IRL640S

ICR

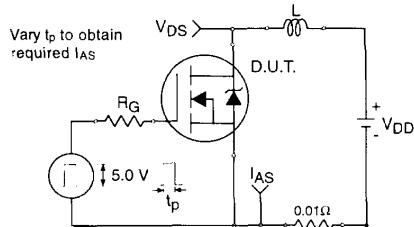


Fig 12a. Unclamped Inductive Test Circuit

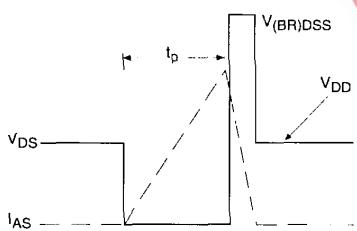


Fig 12b. Unclamped Inductive Waveforms

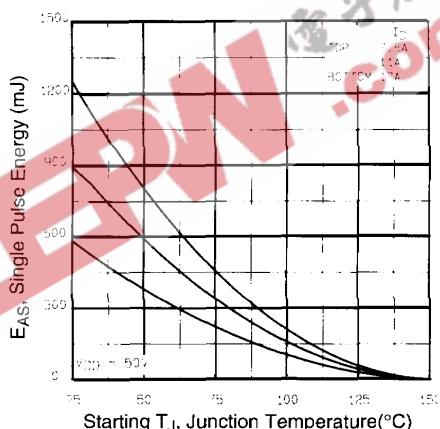


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

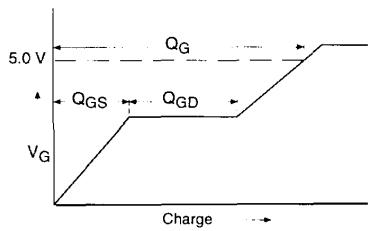


Fig 13a. Basic Gate Charge Waveform

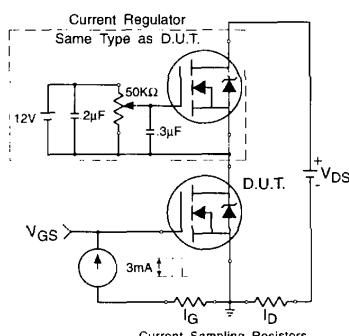


Fig 13b. Gate Charge Test Circuit

Appendix A: Figure 14, Peak Diode Recovery dv/dt Test Circuit

Appendix B: Package Outline Mechanical Drawing

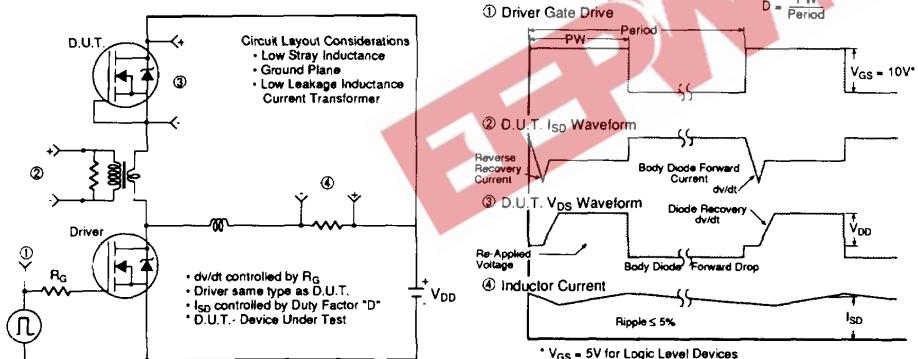
Appendix C: Part Marking Information

Appendix D: Tape & Reel Information

Appendix A

Peak Diode Recovery dv/dt Test Circuit

Fig 14. For N-Channel HEXFETs

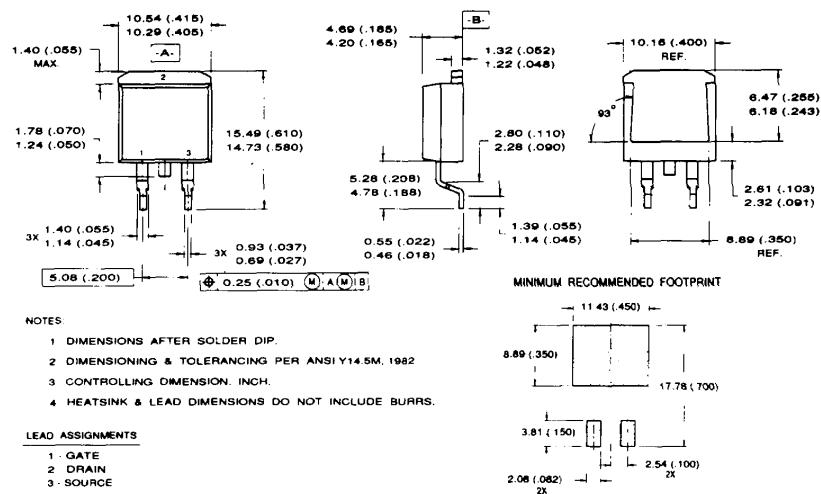


Appendix B

Package Outline

SMD-220 Outline

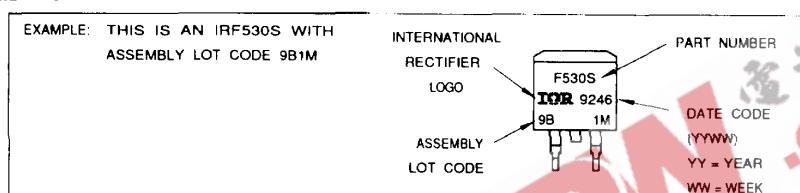
Dimensions are shown in millimeters (inches)



IRL640S

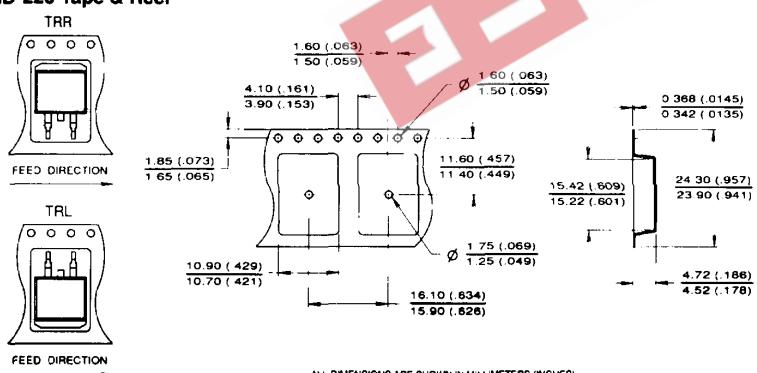


Part Marking Information SMD-220

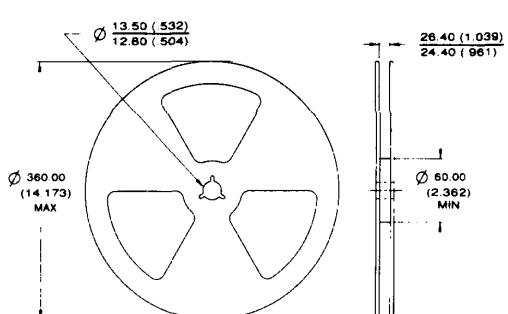


Appendix C

Tape & Reel Information SMD-220 Tape & Reel



Appendix D



SMD-220 Tape & Reel

When ordering, indicate the part number, part orientation, and the quantity. Quantities are in multiples of 800 pieces per reel for both TRL and TRR.



Printed on Signet recycled offset:
made from 50% recycled waste paper, including
10% de-inked, post-consumer waste.



International
IR Rectifier

WORLD HEADQUARTERS: 233 Kansas St., El Segundo, California 90245, Tel: (310) 322-3331, Twx: 4720403
EUROPEAN HEADQUARTERS: Hurst Green, Oxted, Surrey RH8 9BB England, Tel: (0883) 713215, Twx: 95219

IR CANADA: 101 Bentley St., Markham, Ontario L3R 3L1, Tel: (416) 475-1897 IR GERMANY: Saalburgstrasse 157, D-6380 Bad Homburg, Tel: 6172-37066. IR ITALY: V.a Liguria 49 10071 Borgaro, Torino, Tel: (011) 470 1484. IR FAR EAST: K&H Building, 30-4 Nishiikabukuro 3-Chome, Toshima-ku, Tokyo 171 Japan, Tel: (03) 983 0641. IR SOUTHEAST ASIA: 190 Middle Road, HEX 10-01 Fortune Centre, Singapore 0798, Tel: (65) 336 3922.

Sales Offices, Agents and Distributors in Major Cities Throughout the World.

Printed in U.S.A. 8/94 5m Data and specifications subject to change without notice. (1092)